

EMI TEST REPORT

(Class II Permissive Change)

According to FCC Part 15 Subpart B/Class B

Product : Notebook PC

Model No. : P10

FCC ID : A3LSP10

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All tests necessary to show compliance to the requirements were and these results met the specifications requirement.

Date of test : August 06, 2002 ~ August 06, 2002

Issued Date : August 10, 2002

Tested by:

Tae Young, JANG / Test Engineer

Reviewed by:

Yang Soo, KIM / Manager of EMC Lab.

Authorised by:

Kyu Baek, CHUNG / Chief of EMC Lab.

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The test reported herein have been performed in accordance with its terms of registration.



NVLAP Code: 200447

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Distribution

This test report has been made available as follows:

CS Management Center, EMC Laboratory	1 original
Computer Division	1 copy

1. General Information

Applicant : Samsung Electronics Co., Ltd.

Full Address : 416 Maetan 3 Dong, Paldal-Ku,
Suwon City, Kyungki Do, Korea, 442-742

Kind of Product : **Notebook PC**

FCC ID : **A3LSP10**

Project Name : **Taurus / Palomino**

Model & Variant Names : **P10** (Brand Name: Samsung)
Transport T1000 (Brand Name: Micron)
Model 120-180B5 (Brand Name: Best Buy)
Model 120-170B4 (Brand Name: Best Buy)

Test Report Produced by : Tae Young, JANG / Test Engineer

1.1 Product Description

1) Justification

The system was configured for testing in typical fashion use. Cable were attached to each of the available I/O Ports. Where applicable, peripherals were attached to the I/O cables. The mode of operation utilized for testing was selected to best simulate typical EUT use.

Further details of cabling and configuration are shown in the test system configuration.

2) Operating Frequency :

2.0GHz(CPU Speed), 100MHz(Host Clock), 133MHz(SDRAM Clock),
33.3MHz(PCI Clock), 14.318MHz(Ref), 49.512MHz(Audio Clock), 25M(Network)
183MHz(Video Memory Clock), 12.288MHz(Audio Bit Clock), 24.576MHz(Audio C24)
10MHz(Micom Clock), 48MHz(USB Clock), 66.6(Hub), 65MHz(15.0" LCD Clock)

3) Permissive Contents(Alternative LCD)

Units	From	To	Remark
LCD	14.1"	14.1" and 15.0"	Refer to Photographs
# This model is identical to the basic model except for above Unit.			

4) Description of Testing operating mode

Operating Mode	Operating section of EUT
"H" Pattern display & Read / Write	LCD Screen
	External Monitor
	TV monitor
	Hard Disk Drive C: DVD Drive D: LPT1 to printer
Data access	Telecommunications (LAN, Modem)

5) Tested Resolution :

Tested Video mode	Resolutions	Refresh rates	Colors
LCD(15.0")	1024 X 768	60Hz	32bits
Ext. Monitor	1024 X 768	85Hz	32bits
TV Monitor	640 X 480	60Hz	32bits

6) Manufacturer : SAMSUNG Electronics Co., Ltd.

6) Assemble Parts

Item	Specification	Remark
CPU	Intel Pentium IV Northwood 2.0GHz	512KB Cache, 400MHz PSB
Memory	Samsung, 512MB, 2 SODIMM, Max 1GB	
Video Display	Samsung, LCD 15.0", LTN150XB-L01, XGA TFT, 1024X768 Upto 1920 X 1440 Pixels:32-bit colors(LCD)	ATI Mobillity M7
Modem	Samsung, SFM-3200LW, 56Kbps	V.90 compliant/V92 ready
Swap Device	Samsung CD-RW/ DVD Drive Combo SN-308	
Option	Samsung, Memory Stick, SMB-2000W	
MiniPCI	Agere, MPCIA-20/R, 11MBPS, 019492/B	Ruby
HDD	IBM, 20GB, IC25N020ATCS04-0	4200RPM
LAN	10/100 Base-T Ethernet support, Intel Kinnereth	
Adapter	Astec, AD-8019, AC 100~240V FREE-VOLTAGE	80W
Input Device	Keyboard, 19mm pitch, 3mmH travel length, Pointing Device, PS/2 Touchpad w/2 button	
Battery	65Wh, Removable 8-Cell Li-Ion Smart	

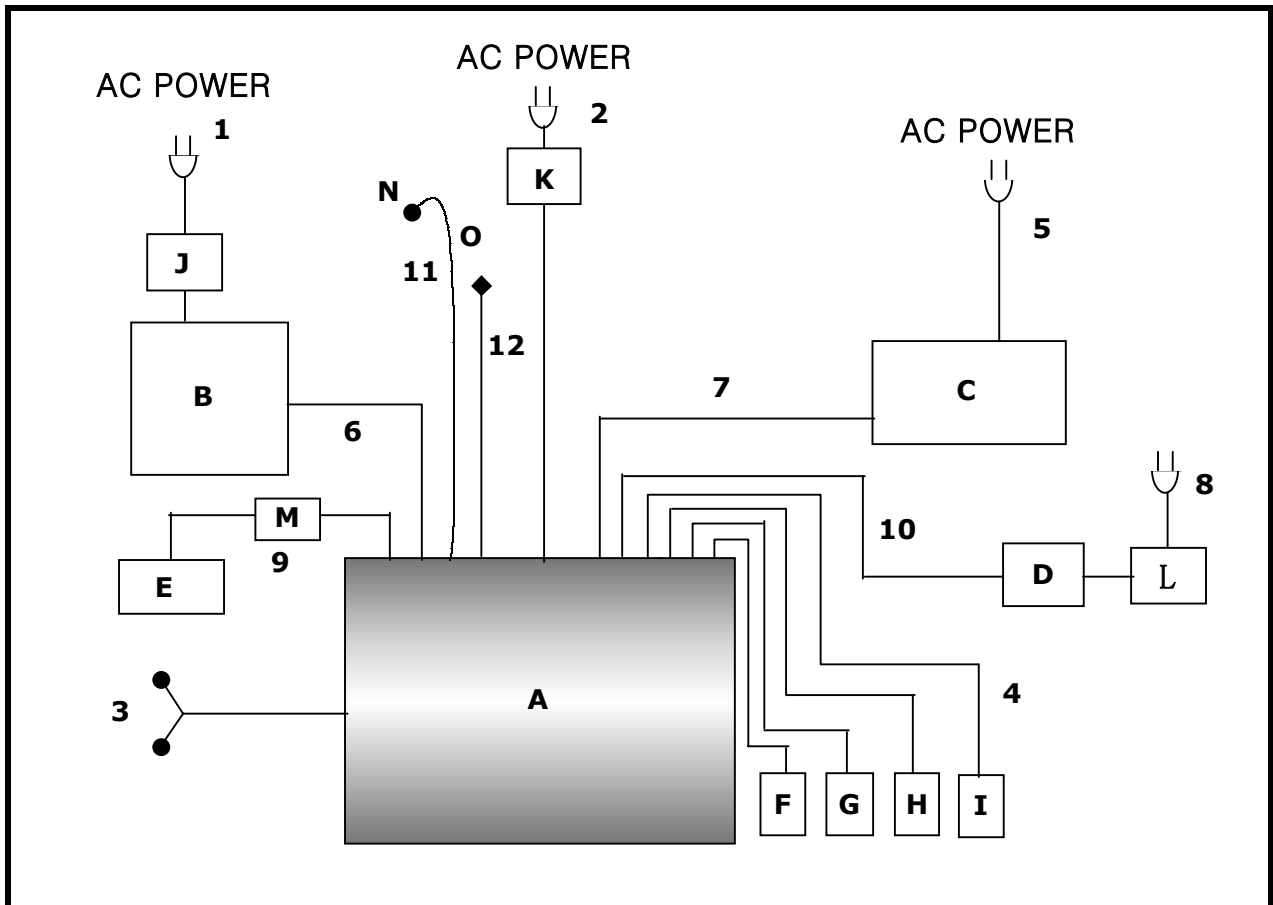
1.2 Configuration of EUT and peripherals

Mark	Item	Model No.	Serial No.	Manufacturer	FCC ID
A	Notebook PC	P10	-	Samsung	A3LSP10
B	Monitor	M17D-AN	N106H4JT100839	Samsung	Doc
C	Printer	LQ-580H	CG2Y0014532	EPSON	Doc
D	TV	CCM052C	54059495	COMMAX	-
E	Digital Camcorder	DCR-PC115	1983343	SONY	-
F	USB Mouse	M-U48a	LZE94654021	LOGITECH	JNZ211360
G	USB Mouse	M-U48a	LZP12500084	LOGITECH	JNZ211360
H	Serial Mouse	M-M35	LZA714452614	LOGITECH	DZL210365
I	PS/2 Mouse	M-S34	LZA70957404	LOGITECH	DZL211029
J	Adapter	AD-4914N	C020280018	Samsung	-
K	Adapter	AD-8019	B3373D01N001B	ASTEC	-
L	Adapter	SA70-3105	6500175	GATEWAY	-
M	Adapter	SA70-3106	6500176	GATEWAY	-
N	Lan Cable	-	-	-	-
O	Modem Cable	-	-	-	-
P	Ear Phone	-	-	-	-

1.3 Used Cable Description

No.	Item	Length[m]	Shielded (Y/N)	Remark
1	AC Power Cable	1.5	N	
2	AC Power Cable	1.5	N	
3	Earphone Cable	1.0	N	
4	Mouse Cable	1.5	N	
5	AC Power Cable	1.5	N	
6	Monitor Cable	1.6	Y	
7	Printer Cable	1.5	Y	
8	AC Power Cable	1.5	N	
9	Camcorder Cable	1.8	N	
10	TV Cable	1.2	N	
11	LAN Cable	5.0	N	
12	Modem Cable	1.7	N	

1.4 System Block Diagram of Test Configuration



1.5 Test Facility

All test described in this report were performed by :

SAMSUNG ELECTRONICS CO., LTD.

EMC TESTING LABORATORY

416 Maetan 3 Dong, Paldal-Ku, Suwon City, Kyungki Do, Korea, 442-742

Semi Anechoic Chamber #2(Registration Number:873282) and Shielded Room.

This test facility has been filed in FCC under the criteria in ANSI C63.4-1992.

2. System Test Configuration

2.1 Configuration of Radiated and Conducted Interference Measurement

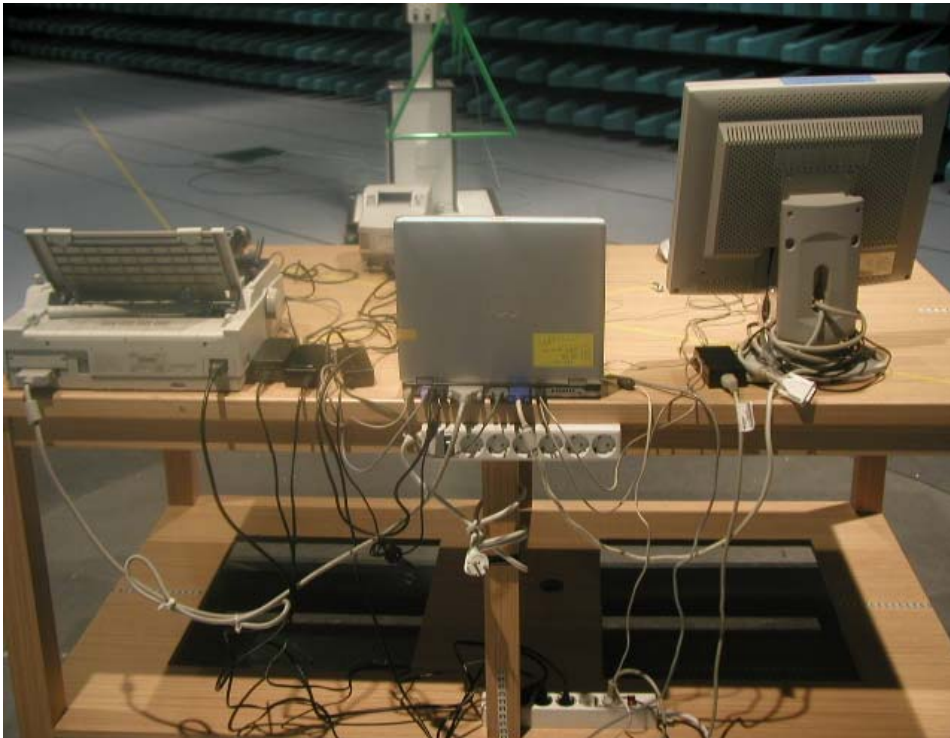
* Cabling was taken into consideration and test data was taken under worse case conditions.

1)Conduction(Front View)



2)Conduction(Rear View)



3) Radiation(Front View)**4) Radiation(Rear View)**

2.2 Operation Environment

	Conduction	Radiation
Temperature [C] :	22C	23C
Humidity [%]	38	38
Power supply	: AC120V/60Hz	AC120V/60Hz

2.3 Test Procedure

2.3.1 Conducted Emissions

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting ground plane.

The rear of EUT, including peripherals was aligned and flush with rear of tabletop. All other surfaces of tabletop was at least 80cm from any other grounded conducting surface. I/O cables and AC cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane.

Each EUT current-carrying power lead, except the ground(safety) lead, were individually connected through a LISN to the input power source.

All unused 50 ohm connectors of the LISN were resistively terminated in 50 ohm when not connected to the measuring equipment.

The EUT was switched on and allowed to warm up to its normal operating condition.

A quick scan, from 150kHz to 30MHz, was made on the L1 & L2 line by LISN.

High peaks, relative to the limit line, over the frequency range were then selected.

The EMI TEST RECEIVER was then tuned to the selected frequencies.

CISPR quasi-peak measurements with a receiver bandwidth setting of 10kHz, were taken.

2.3.2 Radiated Emissions

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane.

The rear of EUT, including peripherals was aligned and flush with rear of tabletop.

I/O cables that were connected to the peripherals were bundle in center.

They were folded back and forth forming a bundle 30cm to 40cm long and were hanged 40cm height to the ground plane.

The system configuration, clock speed, mode of operation or video resolution, turntable azimuth with respect to the antenna were noted for each frequency found.

The spectrum was scanned from 30 to 1000 MHz using biconiLog antenna.

Also, the EMI TEST RECEIVER was scanned from 1000 to 18000MHz using linearly polarized double ridge horn antennas were used.

Each emission was maximized by: varying the mode of operation or resolution; clock or data exchange speed; scrolling H pattern to the EUT and/or support equipment; powering the monitor from the floor mounted outlet box and the computer aux AC outlet if applicable, and changing the polarity of the antenna; whichever determined the worst-case emission.

The explanation of measuring instrument setup when respective function is used in any frequency band is as following:

Frequency Band [MHz]	Instrument	Detector fuction	resolution Bandwidth	Video Bandwidth
30 to 1000	Spectrum analyzer	Peak	1MHz	1MHz
	EMI Test receiver	Quasi-Peak	120kHz	-
Above 1000	EMI Test receiver	Peak	1MHz	-

3. Conducted Emission Test Data

O Test Data Sheet

Frequency [MHz]	Meter reading (a)		Total Loss (b) [dB]	Results (a) + (b)		Limits		Margin (Limits-Result)	
	QP	AV		QP	AV	QP	AV	QP	AV
	[dBuV]			[dBuV]		[dBuV]		[dB]	
0.158	50.3	29.6	0.2	50.5	29.8	65.6	55.6	15.1	25.8
0.181	48.5	24.8	0.2	48.7	25.0	64.4	54.4	15.7	29.5
0.271	48.0	30.4	0.1	48.1	30.5	61.1	51.1	13.0	20.6
0.318	48.3	35.2	0.1	48.4	35.3	59.8	49.8	11.4	14.4
0.439	48.4	32.7	0.1	48.5	32.8	57.1	47.1	8.6	14.3
0.490	48.4	33.3	0.1	48.5	33.4	56.2	46.2	7.7	12.8
0.517	46.4	31.3	0.2	46.6	31.5	56.0	46.0	9.4	14.5
0.533	46.6	26.5	0.2	46.8	26.7	56.0	46.0	9.2	19.4
0.556	46.3	27.3	0.2	46.5	27.5	56.0	46.0	9.5	18.5
0.728	39.2	28.1	0.2	39.4	28.3	56.0	46.0	16.7	17.8
0.818	39.6	24.5	0.2	39.8	24.7	56.0	46.0	16.2	21.3
0.841	39.6	22.3	0.1	39.7	22.4	56.0	46.0	16.3	23.6
6.142	35.0	28.2	0.7	35.7	28.9	56.0	46.0	20.3	17.1
6.505	32.2	20.9	0.7	32.9	21.6	60.0	50.0	27.1	28.5
7.841	30.2	25.1	0.7	30.9	25.8	60.0	50.0	29.1	24.2
14.334	34.7	30.6	0.7	35.4	31.3	60.0	50.0	24.6	18.7
23.127	31.6	27.1	1.0	32.6	28.1	60.0	50.0	27.4	21.9
26.611	33.9	25.4	1.1	34.9	26.4	60.0	50.0	25.1	23.6

* QP : Quasi-peak, AV: Average

* Results = Meter Reading(QP or AV) + Total Loss(LISN Insertion loss + Cable loss)

**"-":The Quasi-peak reading value also meets average limit so it is not necessary to measure with Average detector

* Measurement detector function and bandwidth

Detector function : CISPR quasi-peak

Bandwidth : 10kHz

4. Radiated Emission Test Data

Frequency Range [MHz]	Tested Frequency [MHz]	ANT Pol.	Meter Reading [A] [dBuV/m]	Total Loss [B] [dB]	Antenna Height [Cm]	Turn table Degree [Deg]	Results [A+B] [dBuV/m]	Limits [dBuV/m]	Margin (Limit-Result) [dB]
30 - 88	80.0	H	23.8	7.8	374	306	31.6	40.0	8.4
88 - 216	103.9	V	18.5	12.2	112	330	30.7	43.5	12.8
	106.7	V	19.1	12.5	100	323	31.6	43.5	11.9
	127.0	H	19.6	13.0	262	42	32.6	43.5	10.9
	176.8	H	16.4	10.3	180	305	26.7	43.5	16.8
	181.3	H	15.2	10.0	269	294	25.2	43.5	18.3
	216.0	H	27.6	9.70	150	184	37.3	43.5	6.2
216 - 1000	364.5	V	25.1	17.2	127	231	42.3	46.0	3.7
	486.0	H	11.0	20.1	100	47	31.1	46.0	14.9
	864.1	H	13.5	23.9	100	176	37.4	46.0	8.6
	908.6	V	15.1	24.0	101	351	39.1	46.0	6.9
1000 - 10000	1002.4	V	17.9	26.6	100	120	44.5	74.0	29.5
	1562.3	V	12.3	33.2	100	60	45.5	74.0	28.5

* "<" Means equal or less then 5dB

* Receiving Antenna Mode : **Horizontal, Vertical**

* Results = Meter Reading + Total Loss(Antenna factor + Cable loss)

* Measurement detector function and bandwidth

Detector function : quasi-peak(Above 1000MHz: Peak)

Resolution Bandwidth : 120kHz(Above 1000MHz: 1MHz)

* Test distance

- Below 1000MHz: 3m(Quasi-peak)

- Above 1000MHz: 3m(Peak)

5. FCC Label Configuration and Location

5.1 Label Configuration



5.2 Location of Label



6. Test Equipment Used

Equipment	Model No.	Makers.	Serial No	Calibration Last calibration and Interval
Field strength meter	ESCS30	830986/004	R & S	2003-02-15
	Firmware versions : Main 2.22, OTP 02.01, GRA 02.36			
Test Receiver	ESI26	100010	R&S	2003-05-04
L.I.S.N	ESH2-Z5	831886/006	R & S	2002-11-20
L.I.S.N	ESH3-Z5	831887/0004	R & S	2003-07-27
Bi-Log Antenna	HL562	361324/003	R&S	2003-04-25
Horn Antenna	HF906	100028	R&S	2003-04-26